April 2001

Features

- $R_{\text{DS(ON)}}$ = 12 m Ω @ V_{GS} = 10 V • 54 A, 30 V. $R_{DS(ON)} = 14.5 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$
- Low gate charge (18 nC typical)
- · Fast switching
- High performance trench technology for extremely low R_{DS(ON)}

I-PAK S (TO-251AA) **D-PAK** GDS (TO-252)

Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		30	V
V _{GSS}	Gate-Source Voltage		±16	V
I _D	Drain Current – Continuous	(Note 3)	54	A
	– Pulsed	(Note 1a)	162	
PD	Power Dissipation for Single Operation	(Note 1)	57	W
		(Note 1a)	3.8	
		(Note 1b)	1.6	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +175	°C
Therma	I Characteristics			
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	2.6	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1b)	96	°C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape width	Quantity
FDD6692	FDD6692	D-PAK (TO-252)	13"	12mm	2500 units
FDU6692	FDU6692	I-PAK (TO-251)	Tube	N/A	75

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FDD6692/FDU6692



FDD6692/FDU6692

30V N-Channel PowerTrench® MOSFET

General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low RDS(ON) and fast switching speed.

D

Applications

- DC/DC converter
- Motor drives

G

valanche Ratings (Note urce Avalanche Energy urce Avalanche Current ics purce Breakdown Voltage wn Voltage Temperature nt te Voltage Drain Current dy Leakage, Forward dy Leakage, Reverse ics (Note 2) reshold Voltage ture Coefficient ain–Source stance	$\label{eq:single Pulse, V_{DD} = 15 \ V, \ I_{D} = 14A \\ \hline V_{GS} = 0 \ V, \ I_{D} = 250 \ \mu A \\ \hline I_{D} = 250 \ \mu A, \ Referenced \ to \ 25^{\circ}C \\ \hline V_{DS} = 24 \ V, V_{GS} = 0 \ V \\ \hline V_{GS} = 16 \ V, V_{DS} = 0 \ V \\ \hline V_{GS} = -16 \ V, V_{DS} = 0 \ V \\ \hline V_{DS} = V_{GS}, \ I_{D} = 250 \ \mu A \\ \hline I_{D} = 250 \ \mu A, \ Referenced \ to \ 25^{\circ}C \\ \hline \end{array}$	30	26	165 14 1 1 100 -100	mJ A V mV/°C μA nA
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nt te Voltage Drain Current dy Leakage, Forward dy Leakage, Reverse iCS (Note 2) reshold Voltage reshold Voltage ture Coefficient ain–Source	$\begin{split} V_{DS} &= 24 \ V, \qquad V_{GS} = 0 \ V \\ V_{GS} &= 16 \ V, \qquad V_{DS} = 0 \ V \\ V_{GS} &= -16 \ V, \qquad V_{DS} = 0 \ V \\ \end{split}$	1		100	μA nA
dy Leakage, Forward dy Leakage, Reverse iCS (Note 2) reshold Voltage reshold Voltage reshold Voltage reshold Voltage reshold Voltage reshold Voltage reshold Voltage	$\begin{split} V_{GS} &= 16 \ V, \qquad V_{DS} = 0 \ V \\ V_{GS} &= -16 \ V, \qquad V_{DS} = 0 \ V \\ \end{split} \\ \\ V_{DS} &= V_{GS}, \ I_D = 250 \ \mu A \\ I_D &= 250 \ \mu A, \ Referenced \ to \ 25^\circ C \end{split}$	1	1.6	100	nA
ics (Note 2) reshold Voltage reshold Voltage ture Coefficient ain–Source	$V_{GS} = -16 \text{ V}, V_{DS} = 0 \text{ V}$ $V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$ $I_D = 250 \mu\text{A}, \text{ Referenced to } 25^{\circ}\text{C}$	1	1.6		
ics (Note 2) reshold Voltage reshold Voltage ture Coefficient ain–Source	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$ $I_D = 250 \ \mu A$, Referenced to $25^{\circ}C$	1	1.6	-100	nA
eshold Voltage eshold Voltage ture Coefficient ain–Source	I_D = 250 µA, Referenced to 25°C	1	16		
eshold Voltage Iture Coefficient ain–Source	I_D = 250 µA, Referenced to 25°C	1	16		
ain–Source			1.0	3	V
ain–Source		10	-5		mV/°C
		-		40	
	$V_{GS} = 10 V$, $I_D = 14 A$ $V_{GS} = 4.5 V$, $I_D = 13 A$		9.5 11.5	12 14.5	mΩ
	$V_{GS} = 4.5 \text{ V}, T_D = 13 \text{ K}$ $V_{GS} = 10 \text{ V}, I_D = 14 \text{ A}, T_J = 125^{\circ}\text{C}$		16.5	14.5	
e Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$	50			Α
Transconductance	$V_{DS} = 5 V$, $I_{D} = 14 A$		54		S
toristics		I	1	1	
		I	2164		pF
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	$V_{DD} = 15 V, I_D = 1 A,$		-		ns
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		-	-	25	nC
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ain Charge			5		nC
iode Characteristics	and Maximum Ratings				
m Continuous Drain–Source	e Diode Forward Current			3.2	А
ource Diode Forward	$V_{GS}=0~V,~~I_S=3.2~A~~(\text{Note 2})$		0.72	1.2	V
	cteristics pacitance Capacitance Transfer Capacitance acteristics (Note 2) Delay Time f Delay Time f Delay Time f Fall Time te Charge purce Charge ain Charge	CteristicspacitanceCapacitanceTransfer CapacitanceTransfer Capacitanceacteristics (Note 2)a Delay TimeMise Timef Delay Timef Delay Timef Fall Timete Chargeburce Chargeain Chargebiode Characteristics and Maximum Ratingsm Continuous Drain–Source Diode Forward Current	Cteristicspacitance $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V},$ Capacitancef = 1.0 MHzTransfer CapacitanceImage: Stress of the stress	cteristicspacitance $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, 2164$ Capacitancef = 1.0 MHz357Transfer Capacitance138acteristics (Note 2)Delay Time $V_{DD} = 15 \text{ V}, I_D = 1 \text{ A}, 9 \text{ V}_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ f Delay Time $V_{DS} = 15 \text{ V}, R_{GEN} = 6 \Omega$ f Fall Time10te Charge $V_{DS} = 15 \text{ V}, I_D = 14 \text{ A}, 18 \text{ Purce Charge}$ ain Charge $V_{SS} = 5 \text{ V}$ tiode Characteristics and Maximum Ratingsm Continuous Drain–Source Diode Forward Current	cteristicspacitance $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, 2164$ Capacitance $f = 1.0 \text{ MHz}$ 357 Transfer Capacitance 138 357 acteristics (Note 2) $V_{DD} = 15 \text{ V}, I_D = 1 \text{ A}, 99$ 18 acteristics (Note 2) $V_{DD} = 15 \text{ V}, R_{GEN} = 6 \Omega$ 5 10 f Delay Time $V_{DS} = 15 \text{ V}, R_{GEN} = 6 \Omega$ 5 10 f Delay Time $V_{DS} = 15 \text{ V}, R_{GEN} = 6 \Omega$ 5 10 f Fall Time 10 20 55 56 te Charge $V_{DS} = 15 \text{ V}, I_D = 14 \text{ A}, 18$ 25 purce Charge $V_{GS} = 5 \text{ V}$ 5 5 ain Charge 5 5 5 m Continuous Drain–Source Diode Forward Current 3.2

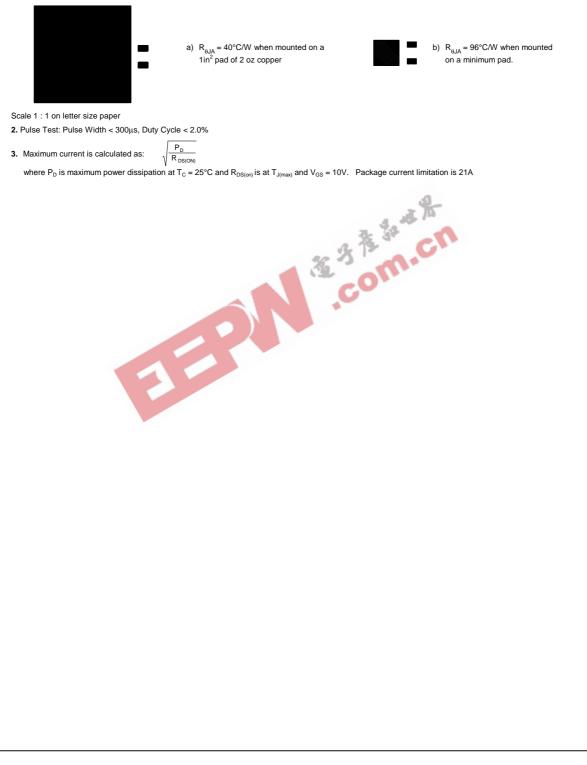
FDD6692/FDU6692

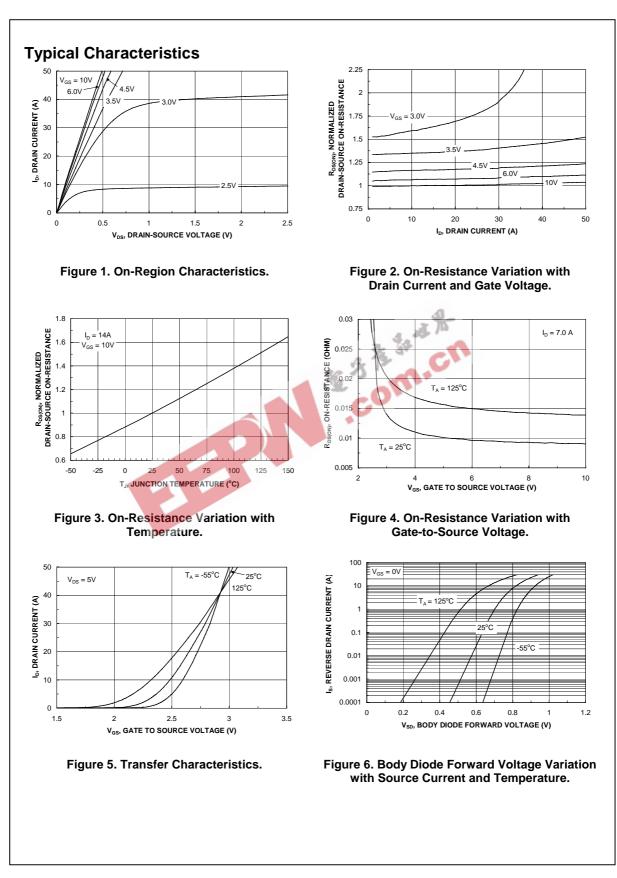
FDD/ FDU6692 Rev. C(W)



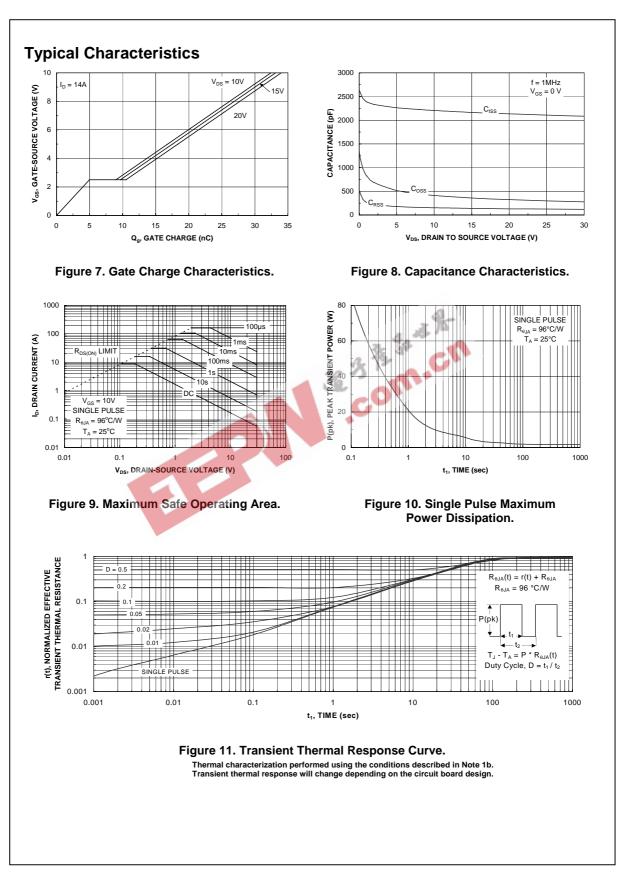


1. R_{8JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{8JA} is guaranteed by design while R_{8CA} is determined by the user's board design.





FDD6692/FDU6692



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ACEx™	FAST ®	PACMAN™	SuperSOT™-3
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E²CMOS™	MicroFET™	SILENT SWITCHER [®]	VCX™
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